



INTERNATIONAL TELECOMMUNICATION UNION

**ITU-T**

TELECOMMUNICATION  
STANDARDIZATION SECTOR  
OF ITU

**0.41**

(10/94)

**SPECIFICATIONS FOR MEASURING EQUIPMENT  
EQUIPMENT FOR THE MEASUREMENT  
OF ANALOGUE PARAMETERS**

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**PSOPHOMETER FOR USE  
ON TELEPHONE-TYPE CIRCUITS**

**ITU-T Recommendation 0.41**

(Previously "CCITT Recommendation")

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## FOREWORD

The ITU-T (Telecommunication Standardization Sector) is a permanent organ of the International Telecommunication Union (ITU). The ITU-T is responsible for studying technical, operating and tariff questions and issuing Recommendations on them with a view to standardizing telecommunications on a worldwide basis.

The World Telecommunication Standardization Conference (WTSC), which meets every four years, establishes the topics for study by the ITU-T Study Groups which, in their turn, produce Recommendations on these topics.

The approval of Recommendations by the Members of the ITU-T is covered by the procedure laid down in WTSC Resolution No. 1 (Helsinki, March 1-12, 1993).

ITU-T Recommendation O.41 was revised by ITU-T Study Group 4 (1993-1996) and was approved under the WTSC Resolution No. 1 procedure on the 15th of October 1994.

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## NOTE

In this Recommendation, the expression "Administration" is used for conciseness to indicate both a telecommunication administration and a recognized operating agency.

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